

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/612,765	QIAN ET AL.
	Examiner	Art Unit
	John L. Goodrow	1756

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	114	5/26/2006	JG
	117		
	137.22		